SDAS098B - OCTOBER 1984 - REVISED JANUARY 1995

- 3-State I/O-Type Read-Back Inputs
- Bus-Structured Pinout
- T/C Determines True or Complementary Data at Q Outputs
- Package Options Include Plastic Small-Outline (DW) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (NT) and Ceramic (JT) 300-mil DIPs

description

These 8-bit latches are designed specifically for storing the contents of the input data bus and providing the capability of reading back the stored data onto the input data bus. The Q outputs are designed with bus-driving capability.

The edge-triggered flip-flops enter the data on the low-to-high transition of the clock (CLK) input when the enable (\overline{EN}) input is low. Data can be read back onto the data inputs by taking the read (\overline{RD}) input low, in addition to having \overline{EN} low. When \overline{EN} is high, both the read-back and write modes are disabled. Transitions on \overline{EN} should only be made with CLK high to prevent false clocking.

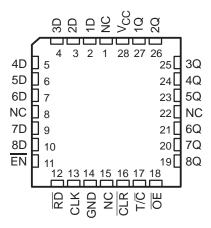
The polarity of the Q outputs can be controlled by the polarity (T/\overline{C}) input. When T/\overline{C} is high, Q is the same as is stored in the flip-flops. When T/\overline{C} is low, the output data is inverted. The Q outputs can be placed in the high-impedance state by taking the output-enable (\overline{OE}) input high. \overline{OE} does not affect the internal operation of the register. Old data can be retained or new data can be entered while the outputs are off.

A low level at the clear ($\overline{\text{CLR}}$) input resets the internal registers low. The clear function is asynchronous and overrides all other register functions.

SN74ALS996 DW OR NT PACKAGE (TOP VIEW)										
1D [2D [3D [3D [5D [5D [5D [5D [7D [8D [8D [8D [7D [8D [7D [8D [7D [8D [7D [7D [7D [7D [7D [7D [7D [7	3 4 5 6 7 8 9 10	24 23 22 21 20 19 18 17 16 15 14 13	Vcc 1Q 2Q 3Q 4Q 5Q 6Q 7Q 8Q 0E T/C CLR							

SN54ALS996 ... JT PACKAGE

SN54ALS996 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

The -1 version of the SN74ALS996 is identical to the standard version, except that the recommended maximum I_{OL} for the -1 version is increased to 48 mA. There is no -1 version of the SN54ALS996.

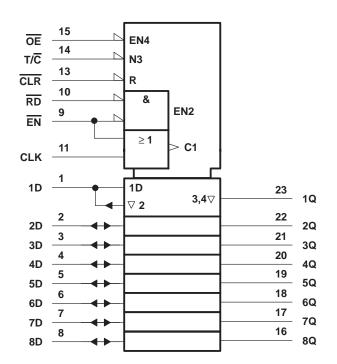
The SN54ALS996 is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74ALS996 is characterized for operation from 0°C to 70°C.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



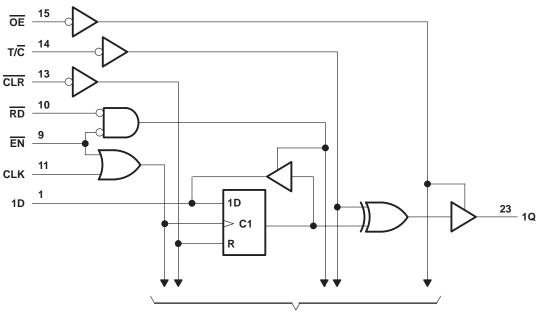
SDAS098B - OCTOBER 1984 - REVISED JANUARY 1995

logic symbol[†]



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the DW, JT, and NT packages.

logic diagram (positive logic)

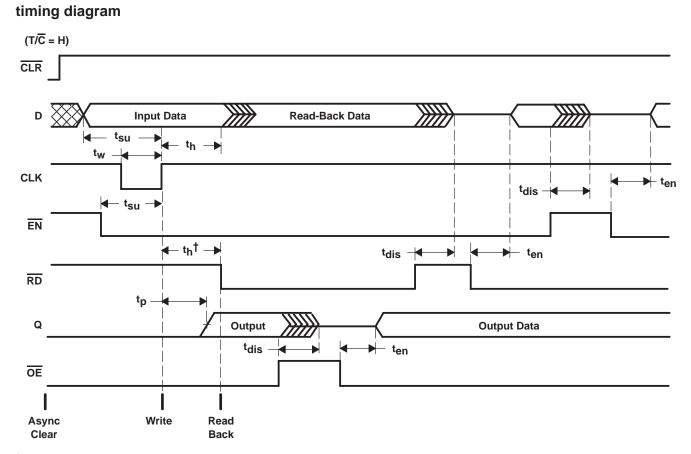


To Seven Other Channels

Pin numbers shown are for the DW, JT, and NT packages.



SDAS098B - OCTOBER 1984 - REVISED JANUARY 1995



[†] This hold time ensures that the read-back circuit will not create a conflict on the input data bus.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[‡]

Supply voltage, V _{CC}	
Input voltage, VI (OE, RD, EN, CLK, CLR, and T/C)	
Voltage applied to D inputs and to disabled 3-state outputs	5.5 V
Operating free-air temperature range, T _A : SN54ALS996	55°C to 125°C
SN74ALS996	
Storage temperature range	. −65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.



SDAS098B - OCTOBER 1984 - REVISED JANUARY 1995

recommended operating conditions

			SN	SN54ALS996		SN	74ALS9	96	UNIT	
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
VCC	Supply voltage		4.5	5	5.5	4.5	5	5.5	V	
		All inputs				2				
VIH	High-level input voltage	All inputs except OE, RD	2						V	
		OE, RD	2.2							
V _{IL}	Low-level input voltage				0.8			0.8	V	
	I Pak Jacob and a summer	Q			-1			-2.6		
IOH	High-level output current	D			-0.4			-0.4	mA	
IOL Low-level outp					12			24		
	Low-level output current	Q						48†	mA	
		D			8			8		
fclock	Clock frequency		0		35	0		35	MHZ	
		CLR low	10			10				
tw	Pulse duration	CLK low	14.5			14.5			ns	
		CLK high	14.5			14.5				
		Data before CLK [↑]	15			15				
	O a transition a	EN low before CLK1	10			10				
t _{su}	Setup time	CLK high before EN↑‡	15			15			ns	
		CLR high (inactive) before CLK [↑]	10			10				
		Data after CLK [↑]	1			0				
t _h	Hold time	EN low after CLK↑	5			5			ns	
		RD high after CLK↑§	5			5				
TA	Operating free-air temperatur	e	-55		125	0		70	°C	

[†] Applies only to the -1 version and only if V_{CC} is maintained between 4.75 V and 5.25 V [‡] This setup time ensures that EN will not false clock the data register. § This hold time ensures that there will be no conflict on the input data bus.



SDAS098B - OCTOBER 1984 - REVISED JANUARY 1995

PARAMETER			TEST CONDITIONS			96	SN	74ALS9	96	
		TEST C				MAX	MIN	TYP†	MAX	UNIT
VIK		V _{CC} = 4.5 V,	lı = – 18 mA			-1.2			-1.2	V
	All outputs	V _{CC} = 4.5 V to 5.5 V,	I _{OH} = - 0.4 mA	Vcc -2	2		V _{CC} -2	2		
∨он		N 45.11	I _{OH} = – 1 mA	2.4	3.2					V
	Q	$V_{CC} = 4.5 V$	I _{OH} = – 2.6 mA				2.4	3.2		
		N 45.11	$I_{OL} = 4 \text{ mA}$		0.25	0.4				
	D	$V_{CC} = 4.5 V$	I _{OL} = 8 mA					0.35	0.5	
VOL			I _{OL} = 12 mA		0.25	0.4		0.25	0.4	V
Q	$V_{\rm CC} = 4.5 \text{V}$	I _{OL} = 24 mA					0.35	0.5		
			I _{OL} = 48 mA [‡]					0.35	0.5	
IOZH	Q	V _{CC} = 5.5 V,	V _O = 2.7 V			20			20	μΑ
IOZL	Q	V _{CC} = 5.5 V,	V _O = 0.4 V			-20			-20	μΑ
	D inputs		VI = 5.5 V			0.1			0.1	
lj	All others	V _{CC} = 5.5 V	V _I = 7 V			0.1			0.1	mA
	D inputs§					20			20	
ΙН	All others	V _{CC} = 5.5 V,	V _I = 2.7 V			20			20	μA
	D inputs§					-0.1			-0.1	
۱	All others	V _{CC} = 5.5 V,	$C = 5.5 V,$ $V_{I} = 0.4 V$			-0.1			-0.1	mA
IO _l		<u>Vcc</u> = 5.5 V, CLR = 2.5 V	V _O = 2.25 V	-20		-112	-30		-112	mA
ICC			Outputs high		35	55		35	55	
		$\frac{V_{CC} = 5.5 \text{ V},}{\text{EN, RD low}}$	Outputs low		55	85		55	85	mA
		Outputs disabled		42	65		42	65		

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

[†] All typical values are at $V_{CC} = 5 \text{ V}, \text{ T}_{A} = 25^{\circ}\text{C}.$

 \ddagger Applies only to the -1 version and only if V_{CC} is maintained between 4.75 V and 5.25 V

 \S For I/O ports (QA thru QH), the parameters IIH and IIL include the off-state output current.

The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.



SDAS098B - OCTOBER 1984 - REVISED JANUARY 1995

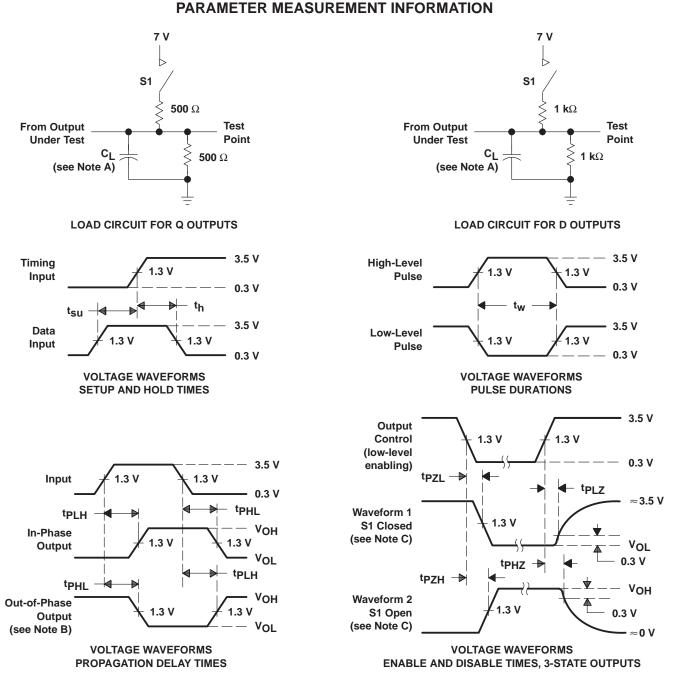
switching characteristics (see Figure 1)

PARAMETER	FROM	то	V _C C _L T _A	UNIT			
	(INPUT)	(OUTPUT)	SN54A	LS996	SN74A	LS996	0.111
			MIN	MAX	MIN	MAX	
fmax			35		35		MHz
^t PLH	CLK (T/C = H or L)	Q	5	30	5	28	20
^t PHL		Q	5	24	5	28	ns
^t PLH	$\overline{\text{CLR}}$ (T/ $\overline{\text{C}}$ = L)	0	5	27	7	27	~~
^t PHL	$\overline{\text{CLR}}$ (T/ $\overline{\text{C}}$ = H)	Q	5	23	7	23	ns
^t PLH	T/C	0	4	23	5	23	20
^t PHL	1/0	Q	5	23	5	23	ns
^t PHL	CLR	D	5	30	8	30	ns
t _{en} ‡		-	2	18	3	16	
t _{dis} §	RD	D	1	19	3	19	ns
t _{en} ‡		5	2	17	3	16	
t _{dis} §	EN	D	1	19	3	19	ns
t _{en} ‡	OE	Q	2	15	4	15	
t _{dis} §	UE	Q	1	11	1	10	ns

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. [‡] t_{en} = t_{PZH} or t_{PZL} § t_{dis} = t_{PHZ} or t_{PLZ}



SDAS098B - OCTOBER 1984 - REVISED JANUARY 1995



NOTES: A. CL includes probe and jig capacitance.

- B. When measuring propagation delay times of 3-state outputs, switch S1 is open.
- C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- D. All input pulses have the following characteristics: $PRR \le 1$ MHz, $t_f = t_f = 2$ ns, duty cycle = 50%.

Figure 1. Load Circuits and Voltage Waveforms





www.ti.com

5-Sep-2011

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/ Ball Finish	MSL Peak Temp ⁽³⁾	Samples (Requires Login)
5962-89945013A	ACTIVE	LCCC	FK	28	1	TBD	Call TI	Call TI	
5962-8994501LA	ACTIVE	CDIP	JT	24	1	TBD	Call TI	Call TI	
SN74ALS996-1DWR	OBSOLETE	SOIC	DW	24		TBD	Call TI	Call TI	
SN74ALS996-1NT	ACTIVE	PDIP	NT	24	15	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	
SN74ALS996-1NTE4	ACTIVE	PDIP	NT	24	15	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	
SN74ALS996DW	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
SN74ALS996DWG4	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
SN74ALS996DWR	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
SN74ALS996DWRE4	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
SN74ALS996DWRG4	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
SN74ALS996NT	ACTIVE	PDIP	NT	24	15	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	
SN74ALS996NT3	OBSOLETE	PDIP	NT	24		TBD	Call TI	Call TI	
SN74ALS996NTE4	ACTIVE	PDIP	NT	24	15	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	
SNJ54ALS996FK	ACTIVE	LCCC	FK	28	1	TBD	POST-PLATE	N / A for Pkg Type	
SNJ54ALS996JT	ACTIVE	CDIP	JT	24	1	TBD	A42	N / A for Pkg Type	
SNJ54ALS996W	OBSOLETE	CFP	W	24		TBD	A42	N / A for Pkg Type	

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.



5-Sep-2011

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above. Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight

in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF SN54ALS996, SN74ALS996 :

Catalog: SN74ALS996

• Military: SN54ALS996

NOTE: Qualified Version Definitions:

• Catalog - TI's standard catalog product

• Military - QML certified for Military and Defense Applications

PACKAGE MATERIALS INFORMATION

www.ti.com

TAPE AND REEL INFORMATION

REEL DIMENSIONS

TEXAS INSTRUMENTS





TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

*All dimensions are nominal

TAPE AND REEL INFORMATION

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74ALS996DWR	SOIC	DW	24	2000	330.0	24.4	10.75	15.7	2.7	12.0	24.0	Q1

TEXAS INSTRUMENTS

www.ti.com

PACKAGE MATERIALS INFORMATION

14-Jul-2012



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74ALS996DWR	SOIC	DW	24	2000	367.0	367.0	45.0

MECHANICAL DATA

MCER004A - JANUARY 1995 - REVISED JANUARY 1997

JT (R-GDIP-T**)

CERAMIC DUAL-IN-LINE

24 LEADS SHOWN



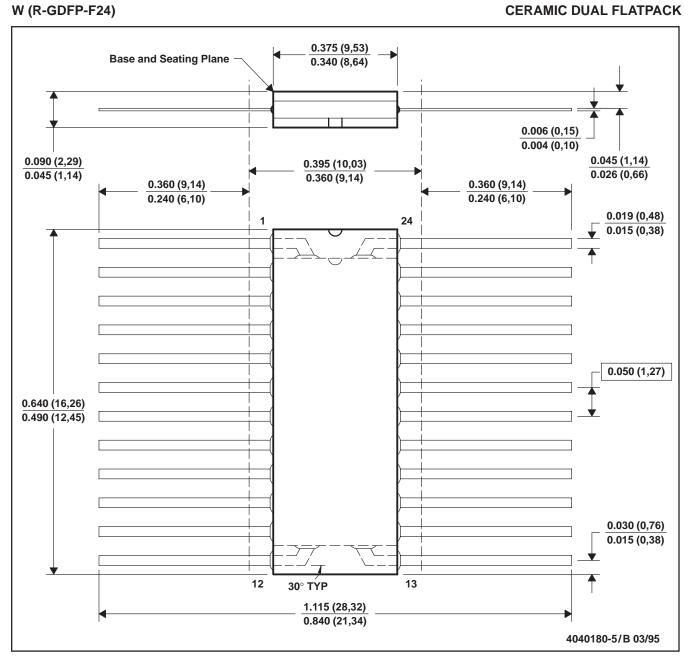
NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification.
- E. Falls within MIL STD 1835 GDIP3-T24, GDIP4-T28, and JEDEC MO-058 AA, MO-058 AB



MECHANICAL DATA

MCFP007 - OCTOBER 1994



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. This package can be hermetically sealed with a ceramic lid using glass frit.

- D. Falls within MIL-STD-1835 GDFP2-F24 and JEDEC MO-070AD
- E. Index point is provided on cap for terminal identification only.



LEADLESS CERAMIC CHIP CARRIER

FK (S-CQCC-N**) 28 TERMINAL SHOWN



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. This package can be hermetically sealed with a metal lid.

D. Falls within JEDEC MS-004



NT (R-PDIP-T**) 24 pins shown

PLASTIC DUAL-IN-LINE PACKAGE



All integrations are in minimeters. Dimensioning and toil
B. This drawing is subject to change without notice.

The 28 pin end lead shoulder width is a vendor option, either half or full width.



DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AD.



IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46C and to discontinue any product or service per JESD48B. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have *not* been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components which meet ISO/TS16949 requirements, mainly for automotive use. Components which have not been so designated are neither designed nor intended for automotive use; and TI will not be responsible for any failure of such components to meet such requirements.

Products		Applications	
Audio	www.ti.com/audio	Automotive and Transportation	www.ti.com/automotive
Amplifiers	amplifier.ti.com	Communications and Telecom	www.ti.com/communications
Data Converters	dataconverter.ti.com	Computers and Peripherals	www.ti.com/computers
DLP® Products	www.dlp.com	Consumer Electronics	www.ti.com/consumer-apps
DSP	dsp.ti.com	Energy and Lighting	www.ti.com/energy
Clocks and Timers	www.ti.com/clocks	Industrial	www.ti.com/industrial
Interface	interface.ti.com	Medical	www.ti.com/medical
Logic	logic.ti.com	Security	www.ti.com/security
Power Mgmt	power.ti.com	Space, Avionics and Defense	www.ti.com/space-avionics-defense
Microcontrollers	microcontroller.ti.com	Video and Imaging	www.ti.com/video
RFID	www.ti-rfid.com		
OMAP Mobile Processors	www.ti.com/omap	TI E2E Community	e2e.ti.com
Wireless Connectivity	www.ti.com/wirelessconnectivity		

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2012, Texas Instruments Incorporated